



SEMiX® 2s

SEMiX302GB17E4s

Features

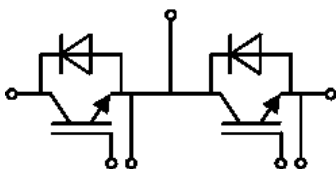
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_J=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 1,95 \Omega$
 $R_{Goff,main} = 1,95 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$



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Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _j = 25 °C		1700	V
I _C	T _j = 175 °C	T _c = 25 °C	516	A
		T _c = 80 °C	392	A
I _{Cnom}			300	A
I _{CRM}	I _{CRM} = 3xI _{Cnom}		900	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 1000 V V _{GE} ≤ 15 V V _{CES} ≤ 1700 V	T _j = 150 °C	10	μs
T _j			-40 ... 175	°C
Inverse diode				
V _{RRM}	T _j = 25 °C		1700	V
I _F	T _j = 175 °C	T _c = 25 °C	324	A
		T _c = 80 °C	238	A
I _{Fnom}			300	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		600	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		1710	A
T _j			-40 ... 175	°C
Module				
I _{t(RMS)}			600	A
T _{stg}			-40 ... 125	°C
V _{isol}	AC sinus 50Hz, t = 1 min		4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 300 \text{ A}$ $V_{GE} = 15 \text{ V}$ chiplevel	$T_J = 25^\circ\text{C}$	1.90	2.20	V
		$T_J = 150^\circ\text{C}$	2.26	2.45	V
V_{CE0}	chiplevel	$T_J = 25^\circ\text{C}$	1.1	1.2	V
		$T_J = 150^\circ\text{C}$	1	1.1	V
r_{CE}	$V_{GE} = 15 \text{ V}$ chiplevel	$T_J = 25^\circ\text{C}$	2.7	3.3	$\text{m}\Omega$
		$T_J = 150^\circ\text{C}$	4.2	4.5	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 12 \text{ mA}$	5.2	5.8	6.4	V
I_{CES}	$V_{GE} = 0 \text{ V}$ $V_{CE} = 1700 \text{ V}$	$T_J = 25^\circ\text{C}$		4	mA
					mA
C_{ies}	$V_{CE} = 25 \text{ V}$ $V_{GE} = 0 \text{ V}$	$f = 1 \text{ MHz}$	24		nF
C_{oes}		$f = 1 \text{ MHz}$	1.00		nF
C_{res}		$f = 1 \text{ MHz}$	0.76		nF
Q_G	$V_{GE} = -8 \text{ V} \dots +15 \text{ V}$		2400		nC
R_{Gint}	$T_J = 25^\circ\text{C}$		2.50		Ω
$t_{d(on)}$	$V_{CC} = 1200 \text{ V}$ $I_C = 300 \text{ A}$	$T_J = 150^\circ\text{C}$	380		ns
t_r	$V_{GE} = +15/-15 \text{ V}$	$T_J = 150^\circ\text{C}$	50		ns
E_{on}	$R_{Gon} = 3.3 \Omega$	$T_J = 150^\circ\text{C}$	140		mJ
$t_{d(off)}$	$R_{Goff} = 3.3 \Omega$	$T_J = 150^\circ\text{C}$	840		ns
t_f	$di/dt_{on} = 6600 \text{ A}/\mu\text{s}$ $di/dt_{off} = 1600 \text{ A}/\mu\text{s}$	$T_J = 150^\circ\text{C}$	160		ns
E_{off}	$du/dt = 4400 \text{ V}/\mu\text{s}$ $L_s = 30 \text{ nH}$	$T_J = 150^\circ\text{C}$	122		mJ



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Typical Applications*

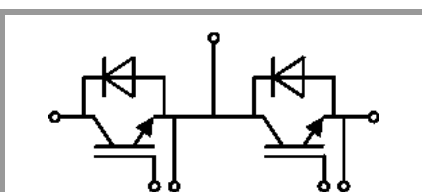
- AC inverter drives
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Remarks

- Case temperature limited to $T_C=125^{\circ}\text{C}$ max.
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Characteristics					
Symbol	Conditions		min.	typ.	max. Unit
$t_{d(on)}$	$V_{CC} = 900 \text{ V}$	$T_J = 150^{\circ}\text{C}$		410	ns
t_r	$I_C = 300 \text{ A}$	$T_J = 150^{\circ}\text{C}$		90	ns
E_{on}	$V_{GE} = +15/-15 \text{ V}$	$T_J = 150^{\circ}\text{C}$		73	mJ
$t_{d(off)}$	$R_{G on} = 3.3 \Omega$	$T_J = 150^{\circ}\text{C}$		780	ns
t_f	$R_{G off} = 3.3 \Omega$	$T_J = 150^{\circ}\text{C}$		170	ns
E_{off}	$di/dt_{on} = 3400 \text{ A}/\mu\text{s}$ $di/dt_{off} = 1400 \text{ A}/\mu\text{s}$ $du/dt = 4400 \text{ V}/\mu\text{s}$ $L_s = 80 \text{ nH}$	$T_J = 150^{\circ}\text{C}$		100	mJ
$R_{th(j-c)}$	per IGBT			0.083	K/W

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 300 A	T _j = 25 °C		1.98	2.37	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		2.11	2.52	V
V _{F0}	chiplevel	T _j = 25 °C	1.16	1.32	1.56	V
		T _j = 150 °C		1.08	1.22	V
r _F	chiplevel	T _j = 25 °C	1.7	2.2	2.7	mΩ
		T _j = 150 °C		3.4	4.3	mΩ
I _{RRM}	I _F = 300 A	T _j = 150 °C		310		A
Q _{rr}	di/dt _{off} = 5600 A/μs	T _j = 150 °C		103		μC
E _{rr}	V _{GE} = -15 V V _R = 1200 V	T _j = 150 °C		70		mJ
I _{RRM}	I _F = 300 A	T _j = 150 °C		300		A
Q _{rr}	di/dt _{off} = 3400 A/μs	T _j = 150 °C		100		μC
E _{rr}	V _{GE} = -15 V V _R = 900 V	T _j = 150 °C		61		mJ
R _{th(j-c)}	per diode				0.184	K/W
Module						
L _{CE}				18		nH
R _{CC'+EE'}	res. terminal-chip	T _C = 25 °C		0.7		mΩ
		T _C = 125 °C		1		mΩ
R _{th(c-s)}	per module			0.045		K/W
M _s	to heat sink (M5)		3		5	Nm
M _t		to terminals (M6)	2.5		5	Nm
						Nm
w					250	g
Temperature Sensor						
R ₁₀₀	T _C =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R _(T) =R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



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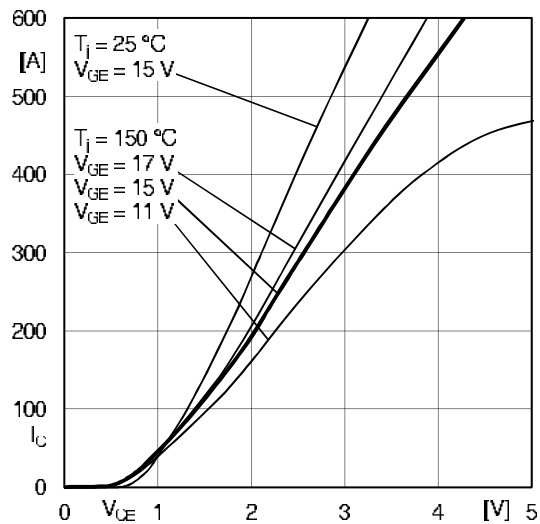
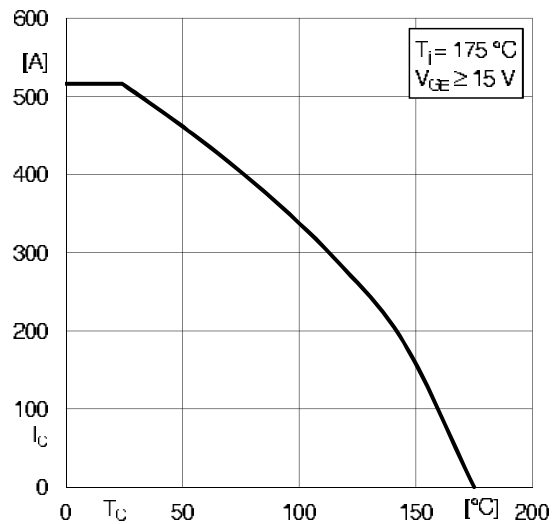
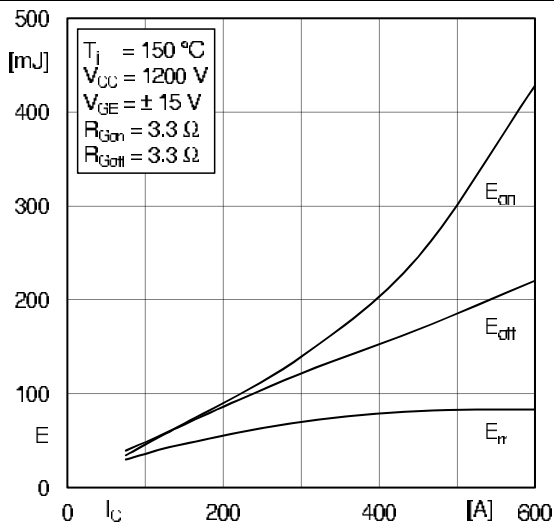
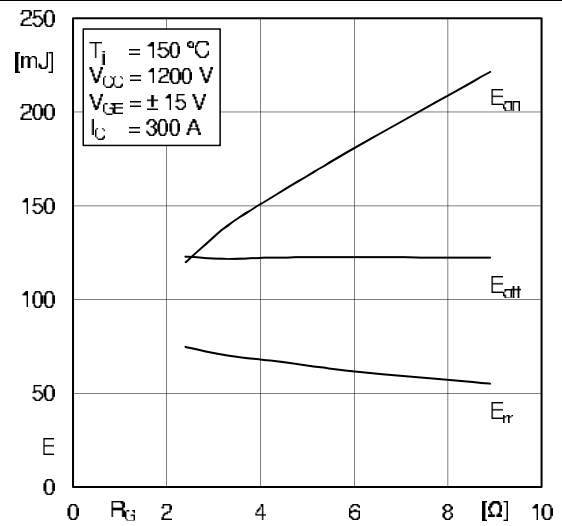
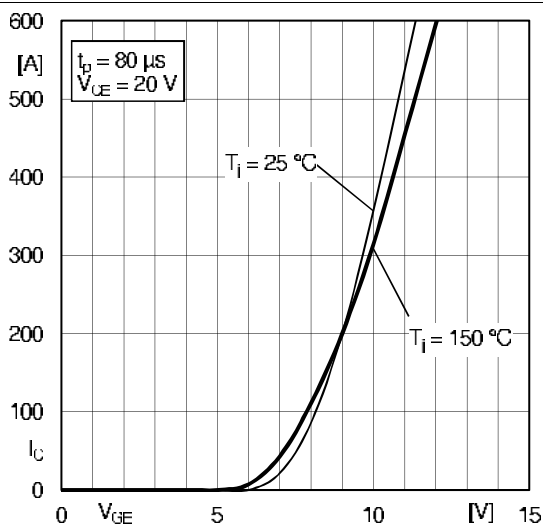
Fig. 1: Typ. output characteristic, inclusive $R_{CC'} + E_{E'}$ Fig. 2: Rated current vs. temperature $I_C = f(T_C)$ Fig. 3: Typ. turn-on /-off energy = $f(I_C)$ Fig. 4: Typ. turn-on /-off energy = $f(R_G)$ 

Fig. 5: Typ. transfer characteristic

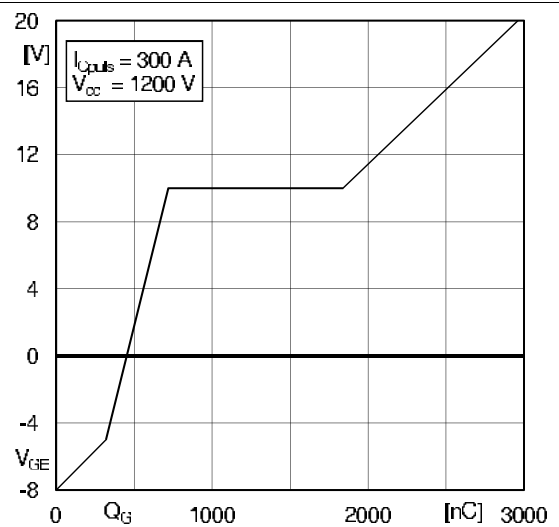


Fig. 6: Typ. gate charge characteristic

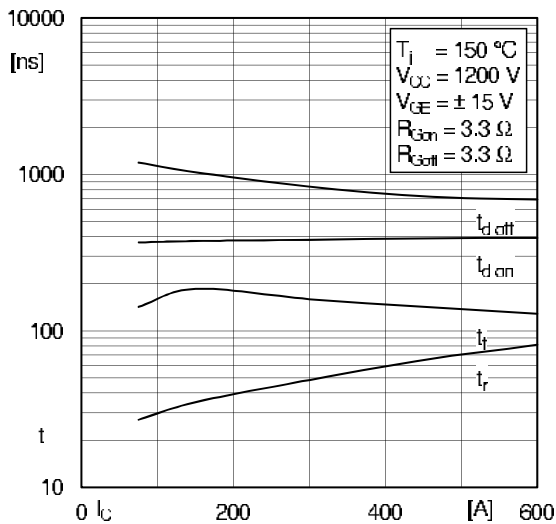


Fig. 7: Typ. switching times vs. I_C

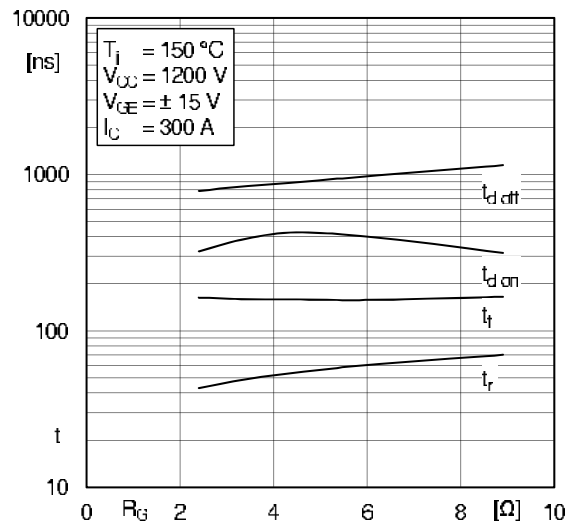


Fig. 8: Typ. switching times vs. gate resistor R_G

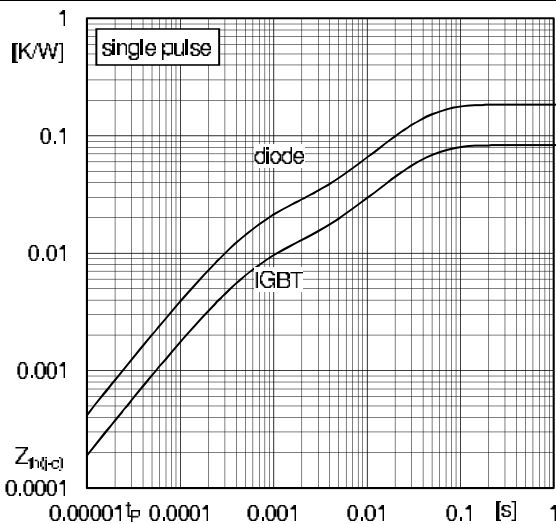


Fig. 9: Typ. transient thermal impedance

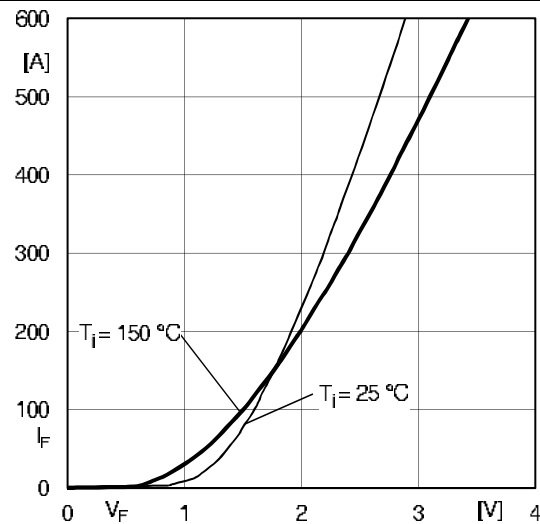


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'}+EE'$

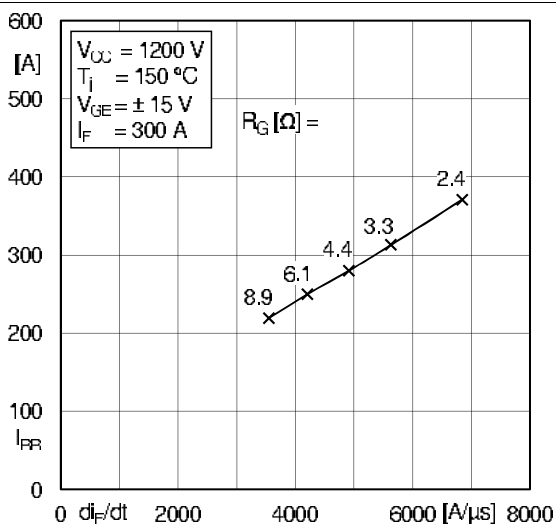


Fig. 11: Typ. CAL diode peak reverse recovery current

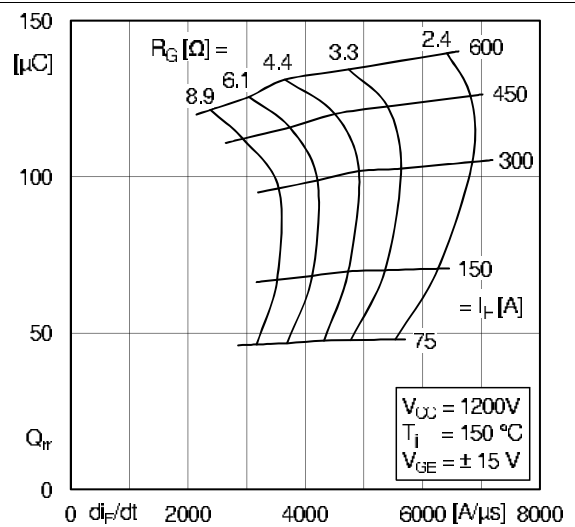


Fig. 12: Typ. CAL diode recovery charge



* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.